

BRIDGMAN-SOLUTION CRYSTAL GROWTH AND CHARACTERIZATION OF THE SKUTTERUDITE COMPOUNDS CoSb_3 and RhSb_3

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Abstract

Compounds with the skutterudite structure have recently been identified as advanced thermoelectric materials. We report on the crystal growth and characterization of the skutterudite compounds CoSb_3 and RhSb_3 which form peritectically at 873 and 900°C, respectively. Large single crystals were obtained by the vertical gradient freeze technique from solutions rich in antimony. The samples were characterized by high temperature Hall effect and electrical resistivity measurements. A band gap of 0.56 and 0.80 eV was estimated from these measurements for CoSb_3 and RhSb_3 , respectively. N-type CoSb_3 samples were obtained by doping with Te. Exceptionally high p-type Hall mobility values have been measured and a room temperature value of $3445 \text{ cm}^2 \cdot \text{V}^{-1} \cdot \text{s}^{-1}$ was obtained for CoSb_3 at a carrier concentration of $4 \times 10^{17} \text{ cm}^{-3}$ and $8000 \text{ cm}^2 \cdot \text{V}^{-1} \cdot \text{s}^{-1}$ was obtained for RhSb_3 at a carrier concentration of $3.5 \times 10^{18} \text{ cm}^{-3}$.

1. Introduction

CoSb_3 and RhSb_3 are members of a large family of compounds which crystallize with the cubic skutterudite structure (CoAs_3), space group $Im\bar{3}(T_h^{25})$ and eight AB_3 groups in the unit cell [1]. The skutterudite compounds have recently been identified as

candidates for advanced thermoelectric materials [2,3,4]. Based on diamagnetism and electrical properties measurements, Hulliger concluded that skutterudite compounds were semiconductors [5]. More recent experimental and theoretical studies [3,6] also confirmed the semiconducting nature of the skutterudite compounds. Up to now almost all the properties of the skutterudite samples were measured on hot-pressed materials. Because of the interest in these materials as thermoelectric and also new semiconductors, the preparation of high quality single crystals is desirable for their characterization. We report on the preparation of single crystals of the peritectic skutterudite compounds CoSb_3 and RhSb_3 . The growth of large single crystals (up to 10 mm long and 10 mm in diameter) by the gradient freeze technique is described. The crystals were investigated by X-ray techniques and also electron probe microanalysis (EPMA). Several properties of the samples were measured in a wide temperature range and the results are discussed.

2. Experimental

The compound CoSb_3 forms peritectically at 873°C [7]. The Co-Sb phase diagram shows that the growth of the compound can be initiated from Sb-rich melts between 91 and about 97 at.% Sb [7]. For RhSb_3 , which forms peritectically at 900°C , the growth can be initiated from Sb-rich melts between 86 and 97 at.% Sb [8]. A two zone-furnace was used and a thermal baffle was introduced between the upper and the lower zone in order to prevent any air convection. An opening of about 12.5 mm in diameter was made in the center of this baffle to introduce the melt container. Details about the furnace used for the growth can be found in reference [9]. The growth was conducted in a sealed quartz ampoule which was stationary during the growth. The temperature close to the upper part of the thermal baffle was controlled by a temperature programmer/controller and a second temperature controller maintained a constant temperature gradient between the upper and the lower zones of the furnace. The furnace was calibrated and temperature gradient as high as $125^\circ\text{C}/\text{cm}$ were obtained near the interface. The growth process was obtained by

lowering the temperature of the furnace and the temperature gradient could be adjusted by changing the difference of temperature maintained between the two zones.

Co (4N) and Sb (6N) were introduced in pointed quartz ampoules, coated with graphite and sealed under vacuum. The nominal composition of the melt was 93 at.% Sb and the total load was about 30 gins. Similarly Rh (3N) and Sb (6N) ampoules were prepared with a nominal composition of 93 at.% Sb. Doping studies were conducted for CoSb_3 using Te as dopant. A temperature gradient of about $50^\circ\text{C}/\text{cm}$ was maintained at the growth interface and the growth rate was about $0.7^\circ\text{C}/\text{hour}$ for both compounds. Samples were cut using a diamond saw and used for microstructure investigations as well as transport property measurements. The microstructure of the samples was investigated using an optical Nikon microscope. Some samples were ground for X-ray diffraction (XRD). XRD analyses were performed on a Siemens D-500 diffractometer using Cu-K_α radiation with silicon as a standard. Laue pictures were taken on several samples to determine their crystallographic orientation. Some samples were mounted in epoxy and polished to perform EPMA on a JEOL JXA-733 superprobe. The density of some samples was measured at room temperature by an immersion technique using toluene as displacement liquid. Samples were also characterized at room temperature by Hall effect and van der Pauw measurements. High temperature Hall effect and electrical resistivity measurements were also performed on selected samples up to about 730°C .

3. Results and discussion

3.1. Crystal growth results

Several ingots of CoSb_3 and RhSb_3 were successfully grown and a typical ingot is shown in Figure 1. As expected, the grown ingots were composed of two parts: the lower

part corresponding to the skutterudite compound and the upper part corresponding to an Sb-rich eutectic. The interface between the two phases was always clearly seen on the ingots (see Figure 1). This interface was very flat which indicates the uniformity of the temperature gradient in the furnace and in the melt as well as the temperature stability during the growth. The lower part of the ingots was cut from the rest of the ingot using a diamond saw and subject to further analysis. Density measurements on the entire lower portions of the ingots showed that the experimental densities were found to be about 99.5 % of the theoretical density of CoSb_3 and RhSb_3 : 7.621 and 7.893 g.cm^{-3} , respective] y. XRD analysis of samples cut from the lower part of the ingots always showed that the samples were single phase with a composition corresponding to the skutterudite structure. EPMA investigations of samples also showed that they were single phase with a composition close to 1:3 with a slight shift towards Sb which could be expected since the crystal were grown from the Sb-rich side and the boundary limit of the solidus was obtained on the Sb-rich side. EPMA of samples from the very tip and the top of the ingots did not show any compositional difference with an accuracy of $\pm 0.2 \text{ at.}\%$. Investigations of polished samples revealed that the samples were crack-free and uniform in composition.

Ingots of CoSb_3 were composed of very large ~g-sins (a few mm) but single crystals as large as $10 \times 10 \times 6 \text{ mm}^3$ were obtained, as indicated by Laue patterns taken on these samples. The orientation of the samples cut perpendicular to the growth axis was found to be close to [101]. The crystals of RhSb_3 were generally smaller than those of CoSb_3 but single crystals with dimensions of $5 \times 5 \times 2 \text{ mm}^3$ were obtained.

3.2. Transport properties

Samples in the form of disks of about 1 mm thick were cut from the single crystalline part of the ingots. In a cubic crystal structure such as the skutterudite, the transport properties are isotropic and no special attention was paid to the orientation of the samples measured. All as-grown samples are p-type with Hall carrier concentration in the 10^{16} to 10^{19} cm^{-3} range for CoSb_3 and between 2 and $7 \times 10^{18} \text{ cm}^{-3}$ for RhSb_3 . It was found that, for the CoSb_3 ingots, the Hall carrier concentration of the samples decreases from the tip to the top of the ingots. Because the ingots were grown from non-stoichiometric melts, during the growth the melt becomes richer in Sb and the stoichiometry of the samples could gradually change along the ingot, resulting in carrier concentration variations. These stoichiometric deviations might be very small and were not detected by EPMA as it was mentioned before. The addition of Te (between 0.1 and 0.2 at.%) into the original melts resulted in n-type samples.

Exceptionally high p-type Hall nobilities were obtained on RhSb_3 and CoSb_3 samples and are shown in Figure 2 which also shows the Hall nobilities of several state-of-the-art semiconductors as a function of the Hall carrier concentration. The Hall mobilities of the two skutterudite compounds are significantly higher than those of Si, Ge and GaAs in the 10^{17} to 10^{19} cm^{-3} carrier concentration range. A maximum Hall mobility of about $8000 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ was obtained for RhSb_3 at a carrier concentration of $3.5 \times 10^{18} \text{ cm}^{-3}$. These high nobilities are consistent with the predominantly covalent bonding in the skutterudite structure and with the fact that the valence band is essentially derived from pnictogen-pnictogen bonds in these materials [10]. Figure 2 also shows the room temperature mobility of n-type CoSb_3 crystals doped with Te. The values compare well with the values for p-type GaAs and Si.

Figure 3 shows the high temperature Hall mobility values for RhSb_3 and CoSb_3 compared to those for Ge, Si and GaAs. The fall-off of the Hall mobility with

temperature for the skutterudite compounds is not too pronounced. From the variations of the resistivity with temperature in the intrinsic regime, the band gap of CoSb_3 and RhSb_3 was estimated at 0.56 and 0.80 eV, respectively. Consequently, the intrinsic regime appears at a lower temperature for CoSb_3 than for RhSb_3 . The high hole mobilities measured on the skutterudite compounds CoSb_3 and RhSb_3 even at high temperatures make these materials interesting new semiconductors and we are planning further studies to investigate their thermoelectric and electronic properties.

4. conclusion

Large single crystals of the peritectic skutterudite compounds CoSb_3 and RhSb_3 were grown from Sb-rich melts by the gradient freeze technique. Characterization of the crystals by X-ray techniques and EPMA show the good quality of the materials. Hall effect and van der Pauw measurements showed that the skutterudite compounds have exceptionally high hole mobilities and good electron mobilities for CoSb_3 . These materials are interesting as new semiconductors and their thermoelectric and electronic properties should be investigated further.

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Figures captions

- Figure 1. Single crystals of CoSb_3 grown by the gradient freeze technique (scale in centimeters).
- Figure 2. Room temperature Hall mobility as a function of Hall carrier concentration for CoSb_3 and RhSb_3 single crystals. The values for Si, Ge and GaAs are also included for comparison.
- Figure 3. High temperature Hall mobility for RhSb_3 and CoSb_3 single crystals and also Si, Ge and GaAs.



collier Figure 1

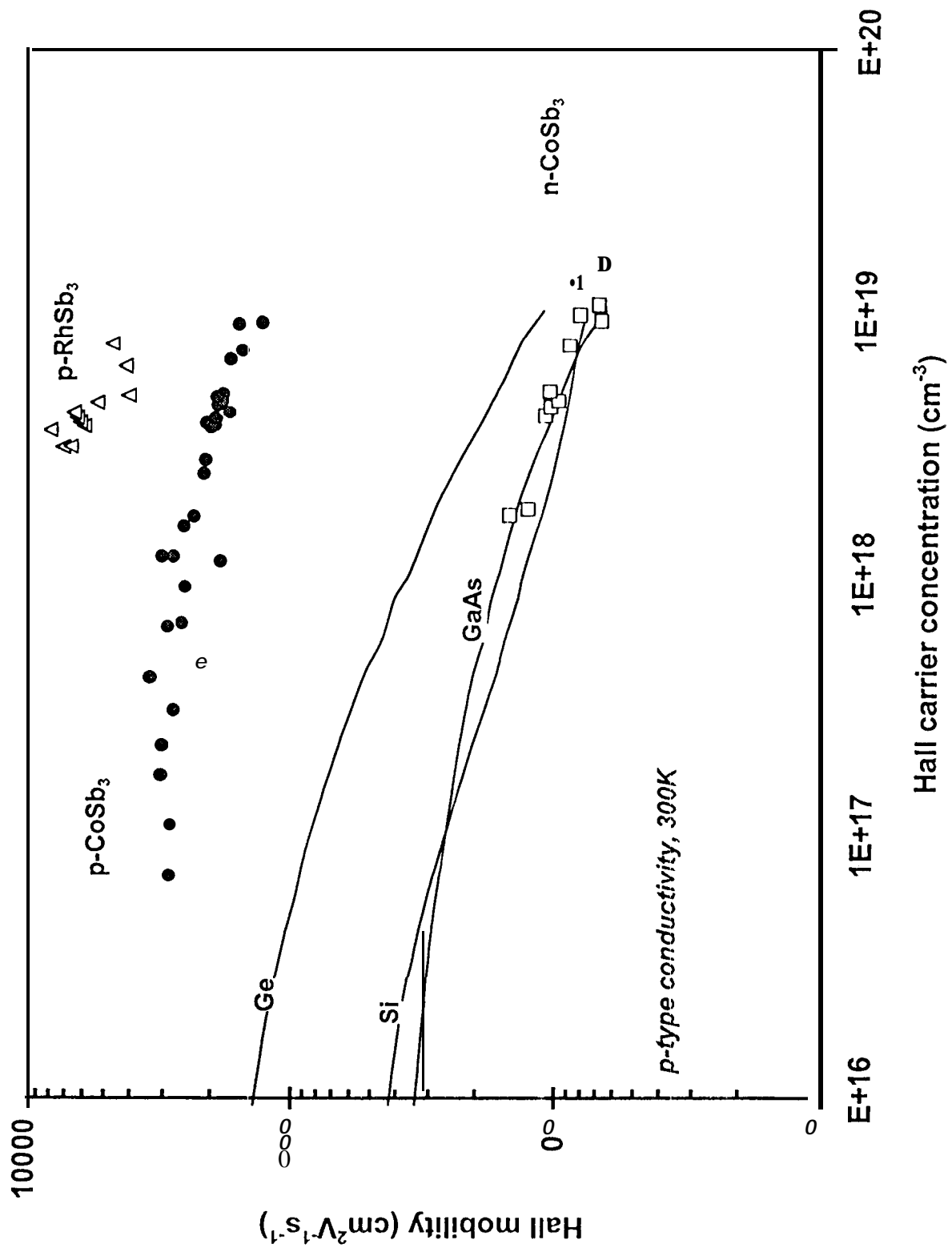


Figure 2 7 (a)

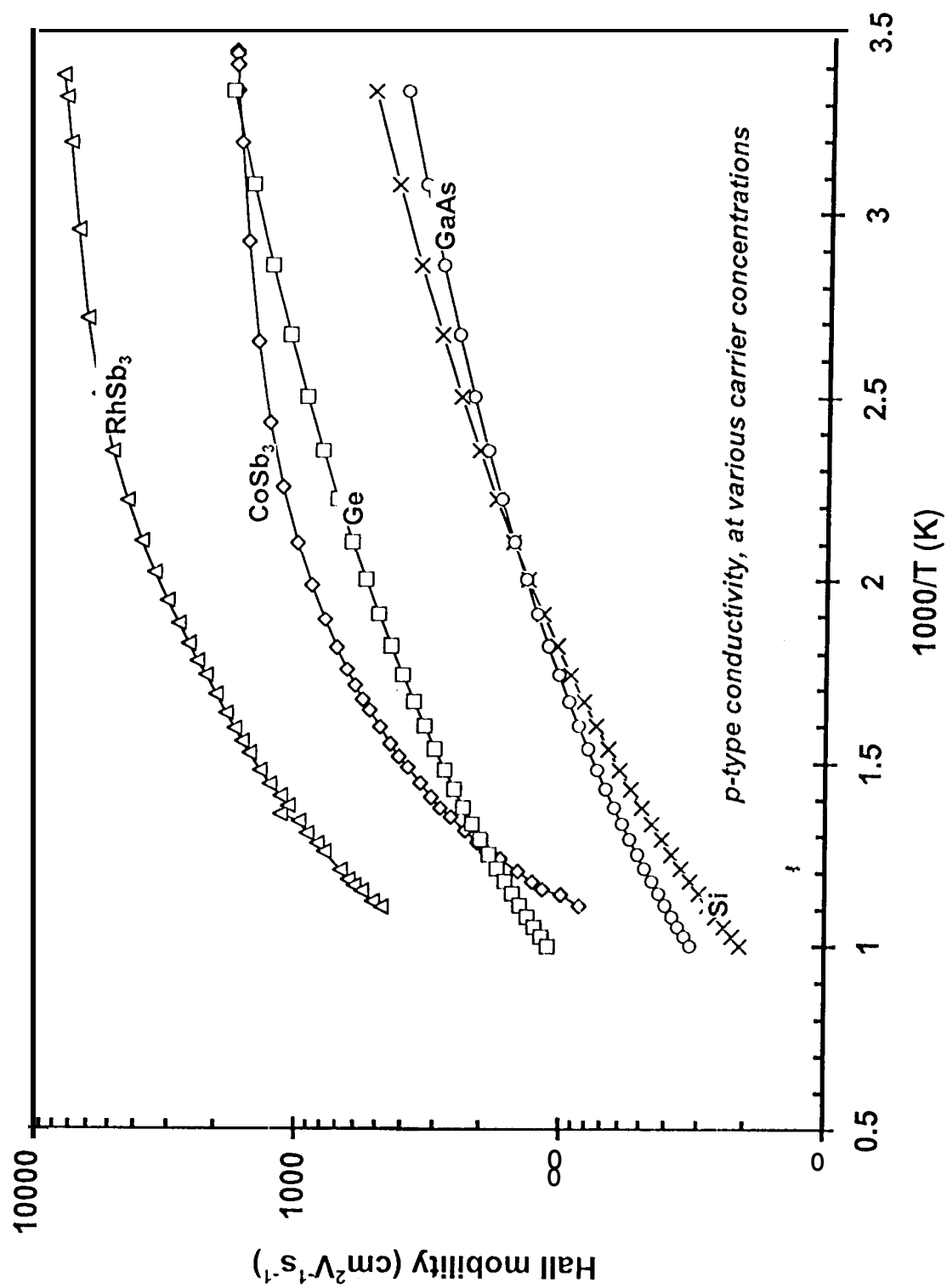


Figure 3 T Coiled